

<b>Notice of References Cited</b>	Application/Control No. 10/663,547	Applicant(s)/Patent Under Reexamination YEN, CHIH-CHEN	
	Examiner KEVIN L. LEE	Art Unit 3753	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,154,394	10-1992	DuHack	251/120
	B	US-5,082,240	01-1992	Richmond	251/120
	C	US-4,420,845	12-1983	Antunez	137/592
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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	V	
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	X	

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